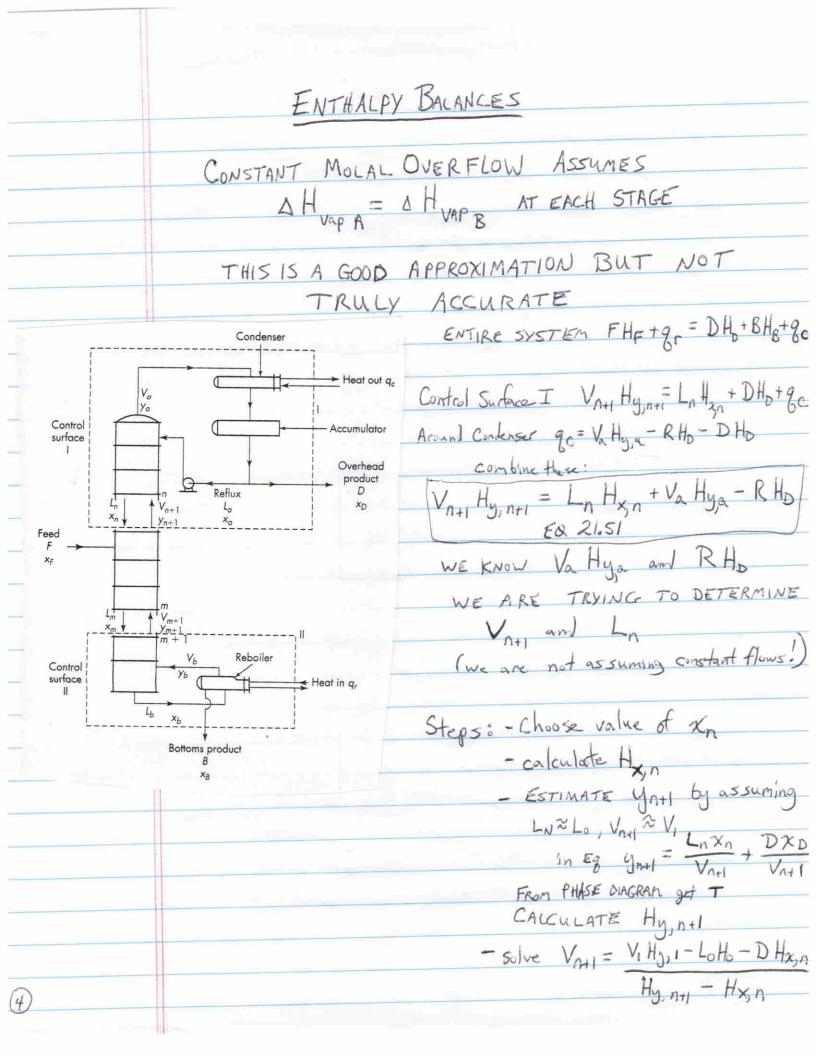
CE 407 LECTURE NOTES 9/19/2017 PARTIAL CONDENSER Partial condenser $y_1 = x_D$ V1 Vapor Vapor Liquid (DAND Liquid ¥ Lcxc Final Liquid condenser D, XD XI Xn Xc (b) (c) (a) FIGURE 21.7 Material-balance diagrams for top plate and condenser: (a) top plate; (a) (b) (b) total condenser; (c) partial and final condensers. **FIGURE 21.8** Graphical construction for top plate: (a) using total condenser; (b) using partial and final condensers. FOR TOTAL CONDENSER MOLE FRACTION IN REFLUX IS EQUAL TO MOLE FRACTION IN PRODUCT IS EQUAL TO MOLE FRACTION IN VAPOR COMING FROM TOP PLATE FOR PARTIAL CONDENSER VAPOR LEAVING PARTIAL CONDENSER HAS SAME MOLE FRACTION AS LIQUID LEAVING FINAL CONDENSER, LIQUID LEAVING PARTIAL CONDENSER IS IN EQUILIBRIUM WITH VAPOR LEAVING PARTIAL CONDENSER PARTIAL CONDENSER BEHAVES LIKE AN ADDITIONAL THEORETICAL STAGE

NEARLY PURE PRODUCTS & WHEN EITHER PRODUCT BECOMES NEARLY PURE THE MCCABE - THIELE STEPS BECOME TOO SMALL TO ACCURATELY BE DRAWN. & WITH NEARLY PURE PRODUCT THE MAJOR COMPONENT FOLLOWS RADULT'S LAW AND THE MINOR COMPONENT FOLLOWS HENRY'S LAW & ANALYZE THE PROCESS AS FOLLOWS: - Choose A HIGH (BUT NOT EXCESSIVELY HIGH) VALUE FOR X cutoff (SAY X = 0.9) - USE STANDARD MCCABE-THIELE TO DETERMINE # of STAGES TO ACHIEVE PRODUCT EQUAL TO THIS X cutoff - DUE TO LOW FRACTION of MINOR COMPONENT THE EQUILIBIUM CURVE IS APPROXIMATELY LINEAR BETWEEN CUT OFF X and Xn - WE CAN USE KREMSER EQUATION TO GET THE NUMBER of STAGES BETWEEN CHTOFF X and XD $N = \frac{\ln \left[(y_{k} - y_{k}^{*}) / (y_{a} - y_{a}^{*}) \right]}{\ln \left[(y_{k} - y_{a}) / (y_{k}^{*} - y_{a}^{*}) \right]}$ EQ 2 20.24

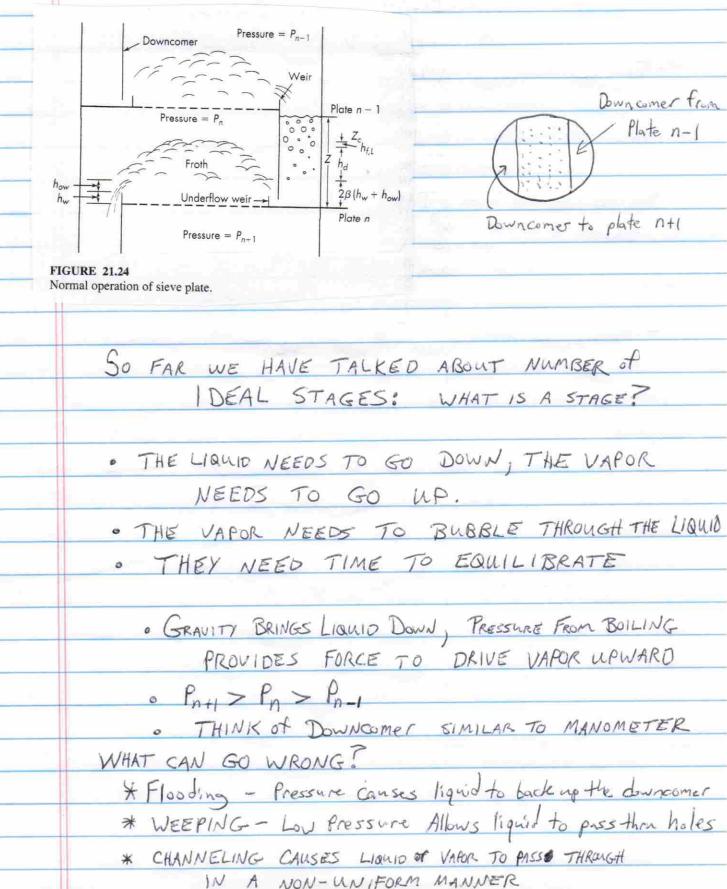
ya is the point on the operating line corresponding to Xa = XD WHERE yb is point on OP line corresponding to Xb = X cutoff chosen Ja is point on equilibrium line corresponding to Xa=XD y * is point on equilibrium line corresponding to Xor = X cutoff chosen Ya and yte can be obtained from y= Rott X + Rott 方 It is obtained from Graph, locate value on equilibrium curve for X = X cutoff A Now EQ LINE Passes through (Xater, yth) and (1,1) solve y=mx+the for thuse two points. Now yat can be calculated to obtain final variable. yat = m x + b A Solve Equation 20.24 with these variables to Johne for N= # of stages between Xcutoff and XD Add N to the number of stages between Xe and X cutoff to obtain total number of stages 3



- USe new value of VAH, cak LA Ln= Vn+1 - D - get improved yn+1 $y_{n+1} = \frac{h_n x_n}{V_{n+1}} + \frac{D x_0}{V_{n+1}}$ Do this for several Xn to get curvature of operating line. WHERE Do the H's come FROM ??! All ENTHALPIES ARE CALCULATE RELATIVE TO A REFERENCE POINT. CHOOSE SATURATED LIQUID AT THE LOWER BOILING POINT of the TWO COMPONENTS TO BE H=O of T=TABP $H_{A,\chi}(T) = H_{A,\chi}(T_{A_{BP}}) + C_{PA,\chi}(T - T_{A_{BP}})$ $= C_{PA,\chi}(T - T_{A_{BP}})$ LIQUIDS $H_{Bx}(T) = H_{B}(T_{ABP}) + C_{P_{B,L}}(T - T_{ABP})$ 3

VAPOR PHASE ENTHALPIES A_{BP} + $\Delta H_V (T_{A_{BP}})$ + $C_{P_{A,V}}(T-T_{A_{BP}})$ HAG (T) PHASE CHANGE Host of Vaporization liquid at TASP SENS IBLE HEAT at Billing Point) + CPB, (T - TABP) p heart comp B to it's Bo'iling point + AH, (TBBP HB liquid # TABP PHASE CHANGE Heatof vaporization at amp B Billing A + $C_{P,BV}(T_{ABP} - T_{BBP}) + C_{PBU}(T$ Cool Unper w/o PINSE CHANGE Back to Comp A Bolling Pt SENSIBLE HEAT SOLUTION : NO HEAT of MIXING IDEAL $H_{\chi} = \chi H_{\chi_A} + (1-\chi) H_{\chi_B}$ Hy = y HyA + (I-y) HyB 6

DESIGN of COLUMNS



VAR PRESSURE DROP mm of liquid hj + h OFressure OP due to DUE TO PLATE equivalent "DRY" head of liquid ie the liquid Total UP in the column $51.0\left(\frac{u^2}{C^2}\right)\left(\frac{Pv}{Pv}\right)$ 0.186 h 01 Us = vapor vebrity though holes my 01 inches of light hy mm of liquid 01 Pu= Vapor density PL = liquid density Co = orifice coefficien Tray thickness diamete 0.90 Hole Discharge coefficient, Co 0.80 0.8 0.6 0 0.1 and less 0.70 0.60 0.20 0.15 0.10 0.05 Hole area/Column area FIGURE 21.25 Discharge coefficients for vapor flow, sieve trays. [I. Liebson, R. E. Kelley, and L. A. Bullington, Petrol. Refin., 36(2):127, 1957; 36(3):288, 1957.] 8

HEAD of LIQUID on PLATE he = B (hw + how) see Fig 21.24 hw is height of weir => design parameter how is how high above weir the liquid level is how = 43.4 (21)33 how = height, mm q = flow rate of clear liquid, min Lw = length of weir, m $0.4 < \beta < 0.7$ USE B20.6 hy tends to be significantly > he 19

Downcomer Level Will we flood? Zc = 2B(hw + how) + hs + hfc hw = height of weir how = height of liquidabove veir h1 = DP through holes hp_ = DP from flow through down comer (THINK of similarity to Manameter) Actual level Z= Ze due to entrained air Ø1= 0.5 (10)

FLOODING CORRELATION MAXIMUM ACCEPTABLE VELOCITY, UC $U_{c} = K_{v} \sqrt{\frac{P_{L} - P_{v}}{P_{v}}} \left(\frac{\sigma}{2\sigma}\right)^{0.2}$ Uc = max vapor velocity based on bubbling arm ft o = surface tension of liquid, dyn 0.7 Plate spacing 0.6 36 in. 0.5 24 in. 0.4 $K_v = u_c (\rho_V / \rho_l - \rho_V)^{0.5} (20 / \sigma)^{0.2}$ 18 in. 0.3 12 in. 9 in. 0.2 6 in. 0.1 0.07 0.06 0.05 0.04 0.03 0.5 0.7 1.0 0.2 0.3 0.05 0.07 0.1 0.02 0.03 0.01 $L/V(\rho_V/\rho_I)^{0.5}$ FIGURE 21.26 Values of K_v at flooding conditions for sieve plates; L/V = ratio of mass flow rate of liquid to vapor, u is in feet per second, and σ is in dynes per centimeter. [J. R. Fair Petrol. Chem. Eng., 33(10):45, 1961. Courtesy Petroleum Engineer.] $\frac{L}{V}\left(\frac{e_v}{2}\right)^2$ With Uc and Knowing V and V as well as what fraction of plate is open for bubbling, we can calculate Column DIAMETER 11